

IEC QUALITY ASSESSMENT SYSTEM (IECQ) covering Electronic Components,

Assemblies, Related Materials and Processes For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 17.0001

CB Certificate No.: 50600164 ITL

Schedule Number: IECQ-L ULTW 17.0001-S Rev No.: 6 Revision Date: 2024/02/11 Page 1 of 2

Appendix-1 (50600164 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
I-V Probe station	WI-LM-0120
InGaAs microscope/Optical Beam Induced Resistance Change (OBIRCH)	WI-LM-0121
Scanning Acoustic Tomography (SAT).	WI-LM-0333
3D X-ray	WI-LM-0324
Secondary Electron Microscope (SEM)	WI-LM-0302
Focused Ion Beam (FIB)	WI-LM-0108
Electrostatic Discharge (ESD) / Latch-up (Heating by Thermo stream)	HBM: ANSI/ESDA/JEDEC JS-001/JESD22-A114 / AEC-Q100-002 / MIL-STD-883 MM: JED22-A115 / AEC-Q100-003 CDM: ANSI/ESDA/JEDEC JS-002 / JESD22-C101 / AEC-Q100-011 Latch-up: JESD78 / AEC-Q100-004
High Temperature Operating Life (HTOL)	JESD22-A108
Bias Life Test (BLT)	JESD22-A108
Early Failure Rate (EFR)	JESD22-A108
High Temperature Storage Life (HTSL)	JESD22-A103
Low Temperature Storage Life (LTSL)	JESD22-A108

This schedule is only valid in conjunction with the referenced Certificate of Approval This approval and any schedule(s) may only be reproduced in full. This approval is not transferable and remains the property of the issuing body. The Status and authenticity of this approval and any schedule(s) may be verified by visiting the Official IECQ Website. <u>www.iecq.org</u>



DQS-Group - DQS Taiwan Inc., Feng Yuan Dist., Taichung City, Taiwan

IECQ-P Schedule of Scope Rev. 01



IEC QUALITY ASSESSMENT SYSTEM (IECQ) covering Electronic Components,

Assemblies, Related Materials and Processes For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 17.0001

CB Certificate No.: 50600164 ITL

Schedule Number: IECQ-L ULTW 17.0001-S

Rev No.: 6 **Revision Date:** 2024/02/11

Page 2 of 2

Highly Accelerated Temperature And Humidity Stress Test (HAST)	JESD22-A110
Unbiased HAST	JESD22-A118
Pressure Cook Test (PCT)	JESD22-A102
Temperature Cycling Test (TCT)	JESD22-A104
Thermal Shock Test (TST)	JESD22-A106
Precondition	IPC/JEDEC J-STD-020D Level 3, JESD22-A113
Steady State Temperature Humidity Bias Life Test (THB)	JESD22-A101
Dye and Pull Test	IPC-TM-650 2.4.53

michael Chou Technical Reviewer of DQS: Date: 02/11/2024

This schedule is only valid in conjunction with the referenced Certificate of Approval This approval and any schedule(s) may only be reproduced in full. This approval is not transferable and remains the property of the issuing body. The Status and authenticity of this approval and any schedule(s) may be verified by visiting the Official IECQ Website. <u>www.iecq.org</u>



DQS-Group - DQS Taiwan Inc., Feng Yuan Dist., Taichung City, Taiwan